NIKO-SEM

N-Channel Enhancement Mode Field Effect Transistor

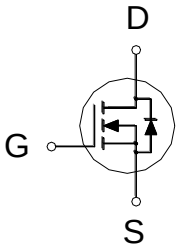
P0920AD

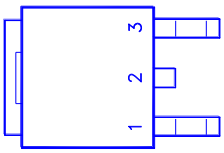
TO-252

Halogen-Free & Lead-Free

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
200	0.42Ω	9A





1. GATE
2. DRAIN
3. SOURCE

RoHS Compliant

ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	T_C = 25 °C	I_D	9	A
	T_C = 100 °C		5.8	
Pulsed Drain Current[1,2]		I_{DM}	36	
Avalanche Current		I_{AS}	9	
Avalanche Energy	L = 2.8mH	E_{AS}	112	mJ
Power Dissipation	T_C = 25 °C	P_D	62	W
	T_C = 100 °C		25	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATING

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		2	°C / W

[1]Pulse width limited by maximum junction temperature.
[2]Limited by package.

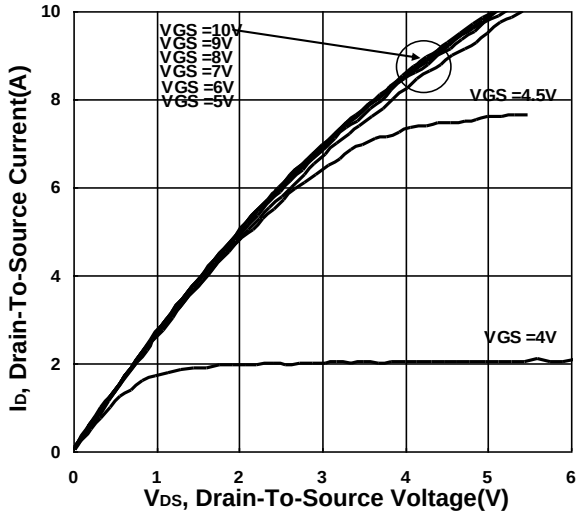
ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0V, I_D = 250μA	200			V
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	2	2.6	4	
Gate-Body Leakage	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 200V, V_{GS} = 0V			1	μA
		V_{DS} = 160V, V_{GS} = 0V, T_J = 125 °C			10	
Drain-Source On-State Resistance[1]	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 4.5A		0.35	0.42	Ω
Forward Transconductance[1]	g_{fs}	V_{DS} = 10V, I_D = 4.5A		10		S

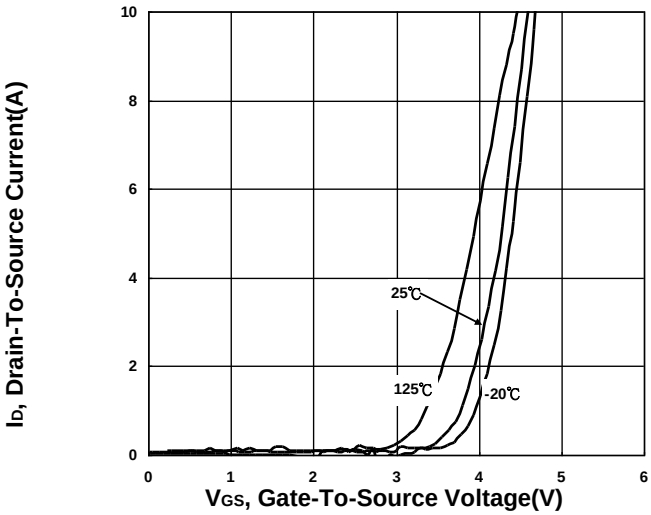
DYNAMIC						
Input Capacitance	C_{iss}	V_{GS} = 0V, V_{DS} = 25V, f = 1MHz		852		nF
Output Capacitance	C_{oss}			122		
Reverse Transfer Capacitance	C_{rss}			25		
Total Gate Charge[2]	Q_g	V_{DS} =160V, V_{GS} = 10V, I_D = 9A		27		nC
Gate-Source Charge[2]	Q_{gs}			3.6		
Gate-Drain Charge[2]	Q_{gd}			13		
Turn-On Delay Time[2]	$t_{d(on)}$	V_{DD} = 100V, $I_D \cong$ 9A, V_{GS} = 10V, R_{GEN} = 6Ω		35		nS
Rise Time[2]	t_r			250		
Turn-Off Delay Time[2]	$t_{d(off)}$			149		
Fall Time[2]	t_f			120		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T_J = 25 °C)						
Continuous Current[2]	I_S				9	A
Forward Voltage[1]	V_{SD}	I_F = 9A, V_{GS} = 0V			1.6	V
Reverse Recovery Time	t_{rr}	I_F = 9A, dI_F/dt = 100A / μS, V_{GS} = 0V		166		nS
Reverse Recovery Charge	Q_{rr}			861		nC

[1]Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.
[2]Independent of operating temperature.

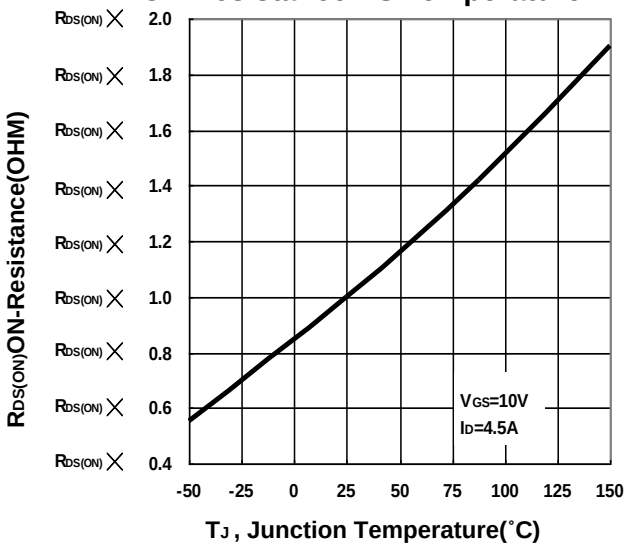
Output Characteristics



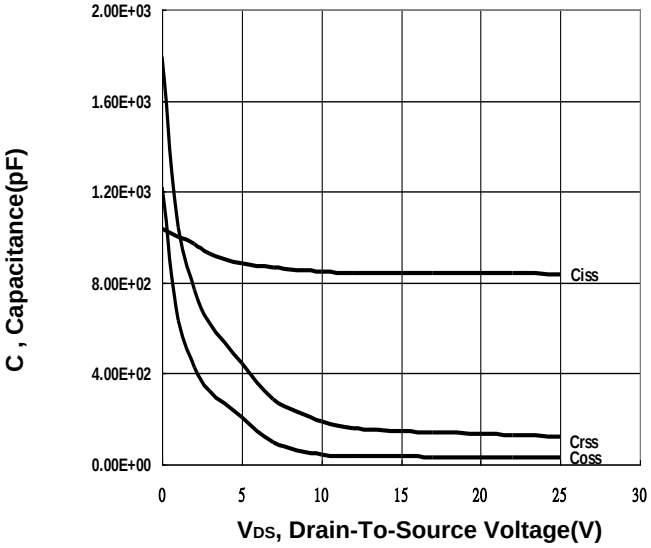
Transfer Characteristics



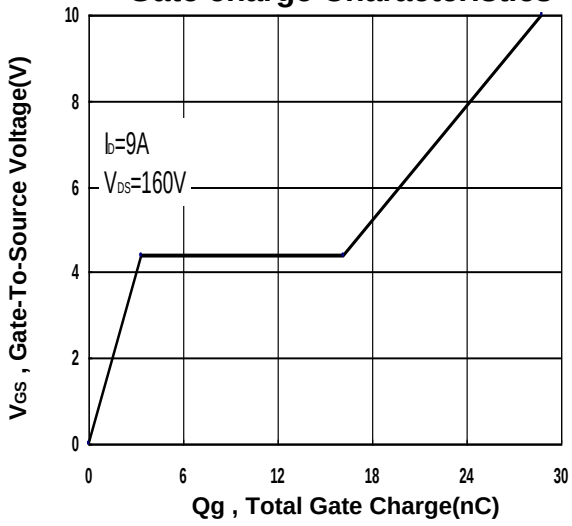
On-Resistance VS Temperature



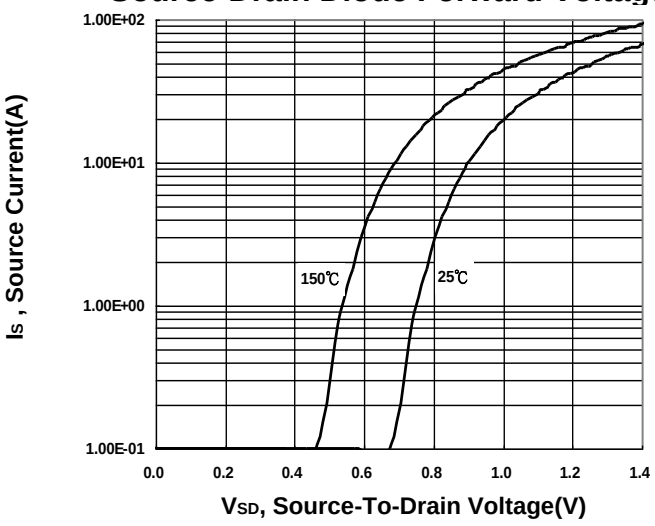
Capacitance Characteristic



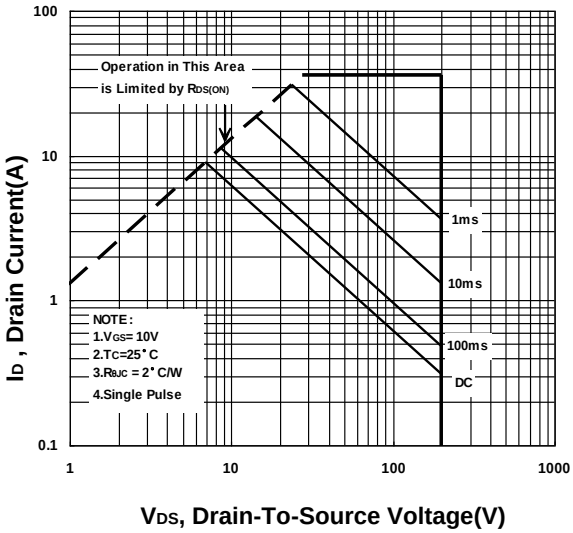
Gate charge Characteristics



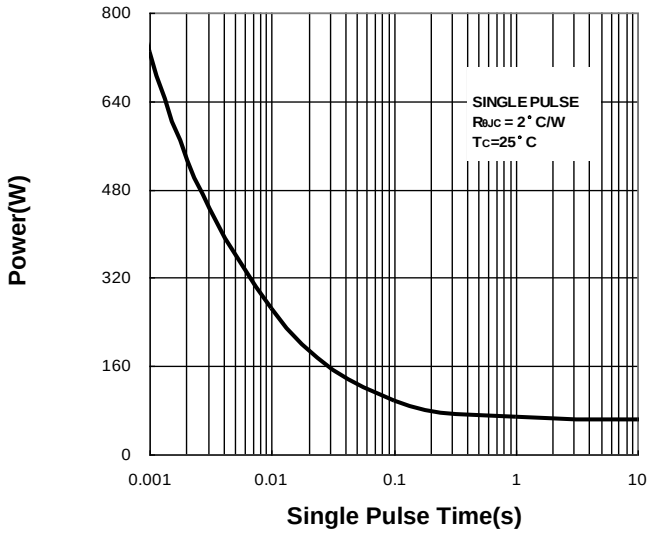
Source-Drain Diode Forward Voltage



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve